TOSHIBA Bipolar Linear Integrated Circuit Silicon Monolithic

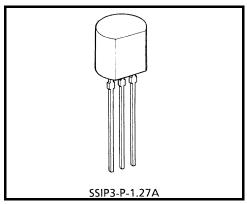
TA78L05S, TA78L07S, TA78L08S TA78L09S, TA78L10S, TA78L12S, TA78L15S

Three-Terminal Positive Voltage Regulators 5 V, 7 V, 8 V, 9 V, 10 V, 12 V, 15 V

The TA78L××S series of fixed voltage monolithic integrated circuit voltage regulators is designed for a wide range of applications.

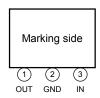
Features

- Suitable for TTL, C²MOS power supply.
- Internal overcurrent protection.
- Internal overheating protection.
- Maximum output current of 100 mA (T_i = 25°C).
- TO-92 package

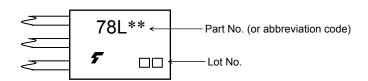


Weight: 0.21 g (typ.)

Pin Assignment

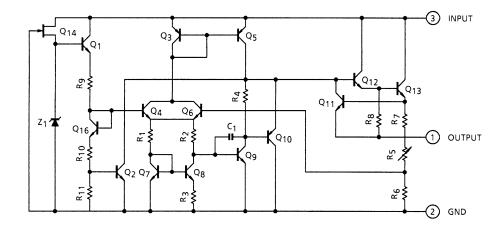


Marking



The product(s) in this document ("Product") contain functions intended to protect the Product from temporary small overloads such as minor short-term overcurrent or overheating. The protective functions do not necessarily protect Product under all circumstances. When incorporating Product into your system, please design the system (1) to avoid such overloads upon the Product, and (2) to shut down or otherwise relieve the Product of such overload conditions immediately upon occurrence. For details, please refer to the notes appearing below in this document and other documents referenced in this document.

Equivalent Circuit



Absolute Maximum Ratings (Ta = 25°C)

Characteris	Symbol	Rating	Unit	
Input voltage	V_{IN}	35	V	
Output current		lout	0.1	Α
Power dissipation	(Ta = 25°C)	P_{D}	600	mW
Operating temperature		T _{opr}	−30 to 85	°C
Storage temperature		T _{stg}	−55 to 150	°C
Junction temperature		Tj	150	°C
Thermal resistance		R _{th (j-a)}	208	°C/W

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).



TA78L05S Electrical Characteristics (Unless otherwise specified, V_{IN} = 10 V, I_{OUT} = 40 mA, C_{IN} = 0.33 μ F, C_{OUT} = 0.1 μ F, 0° C \leq T_{j} \leq 125 $^{\circ}$ C)

Characteristics	Symbol	Test Circuit		Test Condition	Min	Тур.	Max	Unit
Output voltage	V _{OUT}	1	T _j = 25°C		4.8	5.0	5.2	V
Line regulation	Reg·line	1	T _i = 25°C	7.0 V ≤ V _{IN} ≤ 20 V	_	55	150	mV
Line regulation	Reguine	'	1 - 25 C	8.0 V ≤ V _{IN} ≤ 20 V	_	45	100	IIIV
Load regulation	Reg·load	4 7 05	T _i = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	_	11	60	mV
Load regulation	Regiload	1	1 - 25 C	1.0 mA ≤ I _{OUT} ≤ 40 mA	_	5.0	30	IIIV
Output voltage	Vout	1	1 $T_j = 25^{\circ}C$	7.0 V ≤ V _{IN} ≤ 20 V, 1.0 mA ≤ I _{OUT} ≤ 40 mA	4.75	_	5.25	V
				1.0 mA ≤ I _{OUT} ≤ 70 mA	4.75	_	5.25	
Quiescent current	1-	T _j = 25°C	T _j = 25°C		_	3.1	6.0	mA
Quiescent current	I _B	'	T _j = 125°C	T _j = 125°C		_	5.5	IIIA
Quiescent current change	Δl _B	1	T _i = 25°C	8.0 V ≤ V _{IN} ≤ 20 V	_	_	1.5	- mA
Quiescent current change	ΔIB	'	1 - 25 C	1.0 mA ≤ I _{OUT} ≤ 40 mA	_	_	0.1	IIIA
Output noise voltage	V _{NO}	2	Ta = 25°C	, 10 Hz ≤ f ≤ 100 kHz	_	40	_	μV_{rms}
Long term stability	ΔV _{OUT} /Δt	1		_	_	12	_	mV/kh
Ripple rejection	R.R.	3	f = 120 Hz, 8 V ≤ V _{IN} ≤ 18 V, T _j = 25°C		41	49	_	dB
Dropout voltage	V _D	1	T _j = 25°C		_	1.7	_	V
Average temperature coefficient of output voltage	T _{CVO}	1	I _{OUT} = 5 n	nA	_	-0.6	_	mV/°C



TA78L07S Electrical Characteristics (Unless otherwise specified, V_{IN} = 12 V, I_{OUT} = 40 mA, C_{IN} = 0.33 μ F, C_{OUT} = 0.1 μ F, 0° C \leq T_i \leq 125 $^{\circ}$ C)

Characteristics	Symbol	Test Circuit		Test Condition	Min	Тур.	Max	Unit
Output voltage	V _{OUT}	1	T _j = 25°C		6.72	7.0	7.28	V
Line regulation	Pogulino	1	T _j = 25°C	9.2 V ≤ V _{IN} ≤ 22 V	_	50	160	mV
Line regulation	Reg·line	'	1j - 25 C	10 V ≤ V _{IN} ≤ 22 V	_	45	115	IIIV
Load regulation	Poguland	1	T _i = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	_	13	75	mV
Load regulation	Reg·load	'	1 - 25 C	1.0 mA ≤ I _{OUT} ≤ 40 mA	_	6.0	40	IIIV
Output voltage	Vout	1 $T_j = 25^{\circ}C$ 1	9.2 V ≤ V _{IN} ≤ 22 V, 1.0 mA ≤ I _{OUT} ≤ 40 mA	6.65	_	7.35	V	
			1.0 mA ≤ I _{OUT} ≤ 70 mA	6.65	_	7.35		
Quiagant gurrant	1-	T _j = 25°C	T _j = 25°C		_	3.1	6.5	mΛ
Quiescent current	l _B	1	T _j = 125°C		_	_	6.0	- mA
Ouissant aurrent change	A1-	4	T _i = 25°C	10 V ≤ V _{IN} ≤ 22 V	_	_	1.5	mA
Quiescent current change	Δl _B	1	1j = 25 C	1.0 mA ≤ I _{OUT} ≤ 40 mA	_	_	0.1	IIIA
Output noise voltage	V _{NO}	2	Ta = 25°C	, 10 Hz ≤ f ≤ 100 kHz	_	50	_	μV_{rms}
Long term stability	ΔV _{OUT} /Δt	1		_	_	17	_	mV/kh
Ripple rejection	R.R.	3	f = 120 Hz, 10 V ≤ V _{IN} ≤ 20 V, T _j = 25°C		37	46	_	dB
Dropout voltage	V_{D}	1	T _j = 25°C,	T _j = 25°C, I _{OUT} = 100 mA		1.7	_	V
Average temperature coefficient of output voltage	T _{CVO}	1	I _{OUT} = 5 r	nA	_	-0.84	_	mV/°C



TA78L08S Electrical Characteristics (Unless otherwise specified, V_{IN} = 14 V, I_{OUT} = 40 mA, C_{IN} = 0.33 μ F, C_{OUT} = 0.1 μ F, 0° C \leq T_i \leq 125 $^{\circ}$ C)

Characteristics	Symbol	Test Circuit		Test Condition	Min	Тур.	Max	Unit
Output voltage	V _{OUT}	1	T _j = 25°C		7.7	8.0	8.3	V
Line regulation	Reg·line	1	T _i = 25°C	10.5 V ≤ V _{IN} ≤ 23 V	_	20	175	mV
Line regulation	Reguine	'	1 - 25 C	11 V ≤ V _{IN} ≤ 23 V	_	12	125	IIIV
Load regulation	Reg·load	1	T _i = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	_	15	80	mV
Load regulation	Regiload	'	1 - 25 C	1.0 mA ≤ I _{OUT} ≤ 40 mA	_	7.0	40	IIIV
Output voltage	Vout	1	1 $T_j = 25^{\circ}C$ 1	10.5 V ≤ V _{IN} ≤ 23 V, 1.0 mA ≤ I _{OUT} ≤ 40 mA	7.6	_	8.4	V
				1.0 mA ≤ I _{OUT} ≤ 70 mA	7.6	_	8.4	
Quiescent current	1_	T _j = 25°C	T _j = 25°C		_	3.1	6.5	mA
Quiescent current	I _B	1	T _j = 125°C	- Γ _j = 125°C		_	6.0	IIIA
Quiescent current change	Δl _B	1	T _i = 25°C	11 V ≤ V _{IN} ≤ 23 V	_	_	1.5	- mA
Quiescent current change	ΔIB	'	1 - 25 C	1.0 mA ≤ I _{OUT} ≤ 40 mA	_	_	0.1	IIIA
Output noise voltage	V _{NO}	2	Ta = 25°C	, 10 Hz ≤ f ≤ 100 kHz	_	60	_	μV_{rms}
Long term stability	ΔV _{OUT} /Δt	1		_	_	20	_	mV/kh
Ripple rejection	R.R.	3	f = 120 Hz, 12 V ≤ V _{IN} ≤ 23 V, T _j = 25°C		37	45	_	dB
Dropout voltage	V_{D}	1	T _j = 25°C, I _{OUT} = 100 mA		_	1.7	_	V
Average temperature coefficient of output voltage	T _{CVO}	1	I _{OUT} = 5 n	nA		-0.97	_	mV/°C



TA78L09S Electrical Characteristics (Unless otherwise specified, V_{IN} = 15 V, I_{OUT} = 40 mA, C_{IN} = 0.33 μ F, C_{OUT} = 0.1 μ F, 0° C \leq T_i \leq 125 $^{\circ}$ C)

Characteristics	Symbol	Test Circuit		Test Condition	Min	Тур.	Max	Unit
Output voltage	V _{OUT}	1	T _j = 25°C		8.64	9.0	9.36	V
Line regulation	Regiline	1	T _i = 25°C	11.4 V ≤ V _{IN} ≤ 24 V	_	80	200	mV
Line regulation	Regime	'	1j - 25 C	12 V ≤ V _{IN} ≤ 24 V	_	20	160	IIIV
Load regulation	Reg·load	1	T _i = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	_	17	90	mV
Load regulation	Regiload	'	1j - 25 C	1.0 mA ≤ I _{OUT} ≤ 40 mA	_	8.0	45	IIIV
Output voltage	Vout	1	1 $T_j = 25^{\circ}C$	11.4 V ≤ V _{IN} ≤ 24 V, 1.0 mA ≤ I _{OUT} ≤ 40 mA	8.55	_	9.45	V
				1.0 mA ≤ I _{OUT} ≤ 70 mA	8.55	_	9.45	
Quiescent current	1-	T _j = 25°C		_	3.2	6.5	mA	
Quiescent current	I _B	'	T _j = 125°C	T _j = 125°C		_	6.0	IIIA
Quiceant aurrent change	Δ1-	1	T _i = 25°C	12 V ≤ V _{IN} ≤ 24 V	_	_	1.5	mA
Quiescent current change	Δl _B	'	1j - 25 C	1.0 mA ≤ I _{OUT} ≤ 40 mA	_	_	0.1	IIIA
Output noise voltage	V _{NO}	2	Ta = 25°C	, 10 Hz ≤ f ≤ 100 kHz	_	65	_	μV_{rms}
Long term stability	ΔV _{OUT} /Δt	1		_	_	21	_	mV/kh
Ripple rejection	R.R.	3	f = 120 Hz, 12 V ≤ V _{IN} ≤ 24 V, T _j = 25°C		36	44	_	dB
Dropout voltage	V _D	1	T _j = 25°C, I _{OUT} = 100 mA		_	1.7	_	V
Average temperature coefficient of output voltage	T _{CVO}	1	I _{OUT} = 5 n	nA	_	-1.09		mV/°C



TA78L10S Electrical Characteristics (Unless otherwise specified, V_{IN} = 16 V, I_{OUT} = 40 mA, C_{IN} = 0.33 μ F, C_{OUT} = 0.1 μ F, 0° C \leq T_{j} \leq 125 $^{\circ}$ C)

Characteristics	Symbol	Test Circuit		Test Condition	Min	Тур.	Max	Unit
Output voltage	V _{OUT}	1	T _j = 25°C		9.6	10	10.4	V
Line regulation	Dog line	1	T _i = 25°C	12.5 V ≤ V _{IN} ≤ 25 V	_	80	230	mV
Line regulation	Reg·line	'	1j - 25 C	13 V ≤ V _{IN} ≤ 25 V	_	30	170	IIIV
Lond regulation	Poguland	1	T _i = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	_	18	90	mV
Load regulation	Reg·load	'	1j - 25 C	1.0 mA ≤ I _{OUT} ≤ 40 mA	_	8.5	45	IIIV
Output voltage	Vout	1	1 $T_j = 25^{\circ}C$ 1	12.5 V ≤ V _{IN} ≤ 25 V, 1.0 mA ≤ I _{OUT} ≤ 40 mA	9.5	_	10.5	٧
				1.0 mA ≤ I _{OUT} ≤ 70 mA	9.5	_	10.5	
Quiescent current	1-	T _j = 25°C		_	3.2	6.5	mA	
Quiescent current	I _B	1	T _j = 125°C	T _j = 125°C		_	6.0	IIIA
Quissant surrent shangs	A1-	1	T _i = 25°C	13 V ≤ V _{IN} ≤ 25 V	_	_	1.5	- mA
Quiescent current change	Δl _B	'	1 - 25 C	1.0 mA ≤ I _{OUT} ≤ 40 mA	_	_	0.1	IIIA
Output noise voltage	V _{NO}	2	Ta = 25°C	, 10 Hz ≤ f ≤ 100 kHz	_	70	_	μV_{rms}
Long term stability	ΔV _{OUT} /Δt	1		_	_	22	_	mV/kh
Ripple rejection	R.R.	3	f = 120 Hz, 13 V ≤ V _{IN} ≤ 24 V, T _j = 25°C		36	43	_	dB
Dropout voltage	V _D	1	T _j = 25°C,	T _j = 25°C, I _{OUT} = 100 mA		1.7	_	V
Average temperature coefficient of output voltage	T _{CVO}	1	I _{OUT} = 5 r	nA	_	-1.21	_	mV/°C



TA78L12S Electrical Characteristics (Unless otherwise specified, V_{IN} = 19 V, I_{OUT} = 40 mA, C_{IN} = 0.33 μ F, C_{OUT} = 0.1 μ F, 0° C \leq T_{j} \leq 125 $^{\circ}$ C)

Characteristics	Symbol	Test Circuit		Test Condition		Тур.	Max	Unit
Output voltage	V _{OUT}	1	T _j = 25°C		11.5	12	12.5	V
Line regulation	Reg·line	1	T _i = 25°C	14.5 V ≤ V _{IN} ≤ 27 V	_	120	250	mV
Line regulation	Reguine	'	1j - 25 C	16 V ≤ V _{IN} ≤ 27 V	_	100	200	1111
Load regulation	Reg·load	1	T _j = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	_	20	100	mV
Load regulation	Regiload	'	1j - 25 C	1.0 mA ≤ I _{OUT} ≤ 40 mA	_	10	50	1111
Output voltage	V _{OUT}	1 $T_j = 25^{\circ}C$	14.5 V ≤ V _{IN} ≤ 27 V, 1.0 mA ≤ I _{OUT} ≤ 40 mA	11.4	_	12.6	V	
			1.0 mA ≤ I _{OUT} ≤ 70 mA	11.4	_	12.6		
Quiescent current	1_	1 Tj	$T_j = 25^{\circ}C$		_	3.2	6.5	mA
Quiescent current	I _B	'	T _j = 125°C	T _j = 125°C		_	6.0	T IIIA
Quiescent current change	A.I.	1	T _i = 25°C	16 V ≤ V _{IN} ≤ 27 V	_	_	1.5	mA
Quiescent current change	Δl _B	'	1j - 25 C	1.0 mA ≤ I _{OUT} ≤ 40 mA	_	_	0.1	T IIIA
Output noise voltage	V _{NO}	2	Ta = 25°C	, 10 Hz ≤ f ≤ 100 kHz	_	80	_	μV _{rms}
Long term stability	ΔV _{OUT} /Δt	1		_	_	24	_	mV/kh
Ripple rejection	R.R.	3		f = 120 Hz, 15 V ≤ V _{IN} ≤ 25 V, T _j = 25°C		41	_	dB
Dropout voltage	V_{D}	1	T _j = 25°C,	T _j = 25°C, I _{OUT} = 100 mA		1.7	_	V
Average temperature coefficient of output voltage	T _{CVO}	1	I _{OUT} = 5 n	nA	_	-1.45	_	mV/°C

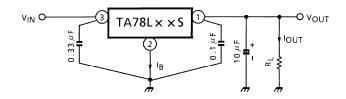


TA78L15S Electrical Characteristics (Unless otherwise specified, V_{IN} = 23 V, I_{OUT} = 40 mA, C_{IN} = 0.33 μ F, C_{OUT} = 0.1 μ F, 0° C \leq T_{j} \leq 125 $^{\circ}$ C)

Characteristics	Symbol	Test Circuit		Test Condition	Min	Тур.	Max	Unit
Output voltage	V _{OUT}	1	T _j = 25°C		14.4	15	15.6	V
Line regulation	Dog line	1	T 25°C	17.5 V ≤ V _{IN} ≤ 30 V	_	130	300	mV
Line regulation	Reg·line	'	T _j = 25°C	20 V ≤ V _{IN} ≤ 30 V	_	110	250	IIIV
Load regulation	Reg·load	1	T _i = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	_	25	150	mV
Load regulation	Regiload	'	1 - 25 C	1.0 mA ≤ I _{OUT} ≤ 40 mA	_	12	75	IIIV
Output voltage	V _{OUT}	1	1 $T_j = 25^{\circ}C$	17.5 V ≤ V _{IN} ≤ 30 V, 1.0 mA ≤ I _{OUT} ≤ 40 mA	14.25	_	15.75	V
				1.0 mA ≤ I _{OUT} ≤ 70 mA	14.25	_	15.75	
Quiogoopt gurrent	1_	T _j = 25°	T _j = 25°C	Γ _j = 25°C		3.3	6.5	mΛ
Quiescent current	ΙB	1	T _j = 125°C	T _j = 125°C		_	6.0	mA
Quiceant ourrent change	A.1	1	T _i = 25°C	20 V ≤ V _{IN} ≤ 30 V	_	_	1.5	- mA
Quiescent current change	Δl _B	'	1j = 25 C	1.0 mA ≤ I _{OUT} ≤ 40 mA	_	_	0.1	IIIA
Output noise voltage	V _{NO}	2	Ta = 25°C	, 10 Hz ≤ f ≤ 100 kHz	_	90	_	μV_{rms}
Long term stability	ΔV _{OUT} /Δt	1		_	_	30	_	mV/kh
Ripple rejection	R.R.	3	f = 120 Hz, 18.5 V ≤ V _{IN} ≤ 28.5 V, T _j = 25°C		34	40	_	dB
Dropout voltage	V _D	1	T _j = 25°C,	I _{OUT} = 100 mA	_	1.7	_	V
Average temperature coefficient of output voltage	T _{CVO}	1	I _{OUT} = 5 n	nA	_	-1.82	_	mV/°C

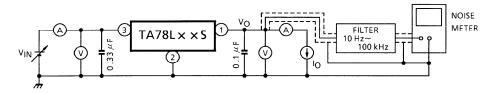


Test Circuit 1 / Standard Application



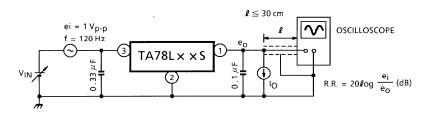
Test Circuit 2

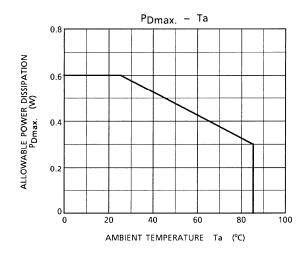
 V_{NO}

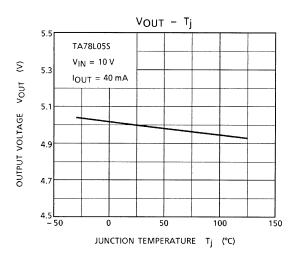


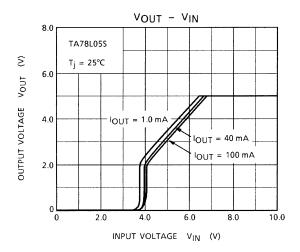
Test Circuit 3

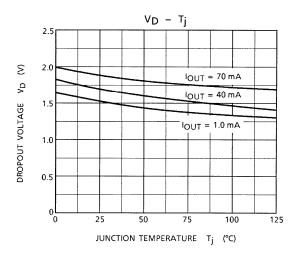
R.R.

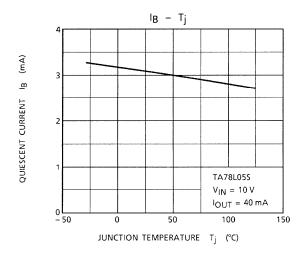


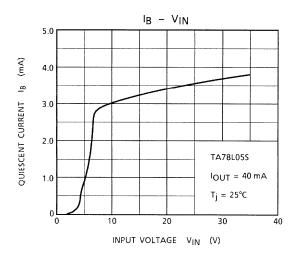


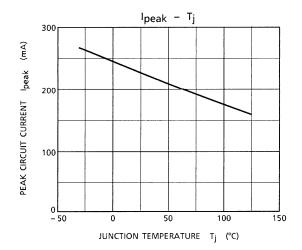


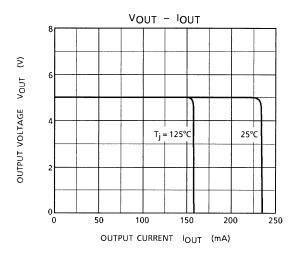






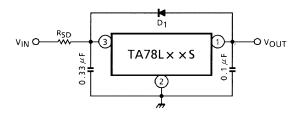






Usage Precautions

Destruction of the IC may occur if high voltage in excess of the IC output voltage (typ. value) is applied to the IC output terminal. Where this possibility exists, connect a Zener diode between the output terminal and GND to prevent any application of excessive voltage.



D₁ : IC protective diode

When surge voltage is applied to IC output terminal or $V_{IN} < V_{OUT}$ at the time of power ON/OFF, always connect the high speed switching diode D1.

R_{SD}: Power limiting resistor

If $V_{\mbox{\scriptsize IN}}$ is too high, always connect RSD in order to reduce power consumption of IC.

• Low voltage

Do not apply voltage to the Product that is lower than the minimum operating voltage, or the Product's protective functions will not operate properly and the Product may be permanently damaged.

• Overcurrent Protection

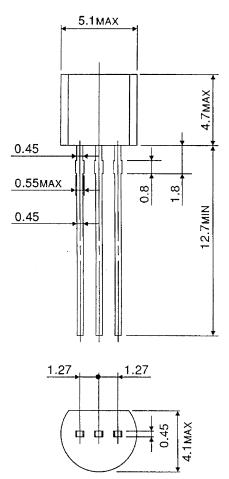
The overcurrent protection circuits in the Product are designed to temporarily protect Product from minor overcurrent of brief duration. When the overcurrent protective function in the Product activates, immediately cease application of overcurrent to Product. Improper usage of Product, such as application of current to Product exceeding the absolute maximum ratings, could cause the overcurrent protection circuit not to operate properly and/or damage Product permanently even before the protection circuit starts to operate.

• Overheating Protection

The thermal shutdown circuits in the Product are designed to temporarily protect Product from minor overheating of brief duration. When the overheating protective function in the Product activates, immediately correct the overheating situation. Improper usage of Product, such as the application of heat to Product exceeding the absolute maximum ratings, could cause the overheating protection circuit not to operate properly and/or damage Product permanently even before the protection circuit starts to operate.

Package Dimensions

SSIP3-P-1.27A Unit: mm



Weight: 0.21 g (Typ.)



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